

# Semicustom

## CMOS

# Standard cell

# CS81 Series

## ■ DESCRIPTION

The CS81 series 0.18  $\mu\text{m}$  CMOS standard cell is a line of highly integrated CMOS ASICs featuring high speed and low power consumption.

This series incorporates up to 40 million gates which have a gate delay time of 11 ps, resulting in both integration and speed about three times higher than conventional products.

In addition, CS81 can operate at a power-supply voltage of down to 1.1 V, substantially reducing power consumption.

## ■ FEATURES

- Technology : 0.18  $\mu\text{m}$  silicon-gate CMOS, 3- to 6-layer wiring capable of integrating a mixture of high-speed processes and cells on a single chip (under development)
  - Supply voltage : +1.8 V  $\pm$  0.15 V (normal) to +1.1 V  $\pm$  0.1 V
  - Junction temperature range : -40 to +125  $^{\circ}\text{C}$
  - Gate delay time :  $t_{pd} = 11$  ps (1.8 V, inverter, F/O = 1)
  - Gate power consumption :  $P_d = 5$  nW/MHz/BC (1.1 V, 2-NAND, F/O = 1)
  - Support for high speed (62.2 Mbps to 780 Mbps, 2.5 Gbps to 3.125 Gbps) interface macros for transmission
  - Output buffer cells with noise reduction circuits
  - Inputs with on-chip input pull-up/pull-down resistors (33 k $\Omega$  typical) and bidirectional buffer cells
  - Buffer cells dedicated to crystal oscillators
  - Special interfaces (P-CML, LVDS, PCI, AGP, USB, SDRAM-I/F, SSTL, and others. including those under development)
  - IP macros (CPU (FR, ARM7, ARM9), DSP, PCI, IEEE1394, USB, IrDA, PLL, ADC, DAC, and others. including those under development)
  - Capable of incorporating compiled cells (RAM/ROM/multiplier, and others.)
  - Configurable internal bus circuits
  - Advanced hardware/software co-design environment
  - Short-term development using a timing driven layout tool
  - Support for static timing sign-off
- Dramatically reducing the time for generating test vectors for timing verification and the simulation time

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# CS81 Series

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- Hierarchical design environment for supporting large-scale circuits
- Simulation (before layout) considering the input slew rate and detailed RC delay calculation (after layout) , supporting development with minimized timing trouble after trial manufacture
- Support for memory (RAM/ROM) SCAN
- Support for memory (RAM) BIST
- Support for boundary SCAN
- Support for path delay test
- A variety of package options (TQFP, HQFP, EBGA, FBGA, TAB-BGA, FCBGA, LQFP)

## ■ MACRO LIBRARY (Including macros being prepared)

### 1. Logic cells (about 400 types)

- Adder
- AND-OR Inverter
- Clock Buffer
- Latch
- NAND
- AND
- NOR
- SCAN Flip Flop
- ENOR
- AND-OR
- Decoder
- Non-SCAN Flip Flop
- Inverter
- Buffer
- OR-AND
- OR-AND Inverter
- OR
- Selector
- BUS Driver
- EOR
- Others

### 2. IP macros

CPU/DSP	FR, SPARClike, ARM7, ARM9, Communications DSP, DSP for AV and others
High speed interface macros	622 Mbps to 780 Mbps, 2.5 Gbps to 3.125 Gbps
Interface macro	PCI, IEEE1394, USB, IrDA, and others
Multimedia processing macros	JPEG, MPEG, and others
Mixed signal macros	ADC, DAC, OPAMP, and others
Compiled macros	RAM, ROM, multiplier, adder, multiplier-accumulator, and others
PLL	Analog PLL, digital PLL

### 3. Special I/O interface macros

- T-LVTTL
- LVDS
- IEEE1394
- SSTL
- PCI
- SDRAM-I/F
- HSTL
- AGP
- P-CML
- USB

## ■ COMPILED CELLS

Compiled cells are macro cells which are automatically generated with the bit/word configuration specified. The CS81 series has the following types of compiled cells. (Note that each macro is different in word/bit range depending on the column type.)

### 1. Clock synchronous single-port RAM (1 address : 1 RW)

- High density type/Partial write type

Column type	Memory capacity	Word range	Bit range	Unit
4	16 to 72 K	16 to 1 K	1 to 72	bit
16	64 to 72 K	64 to 4 K	1 to 18	bit

- High speed type

Column type	Memory capacity	Word range	Bit range	Unit
8	256 to 144 K	64 to 2 K	4 to 72	bit

- Large scale partial write type

Column type	Memory capacity	Word range	Bit range	Unit
16	24.5 K to 1179 K	4 K to 16 K	6 to 72	bit

### 2. Clock synchronous dual-port RAM (2 addresses : 1 RW, 1 R)

- High density type/Partial write type

Column type	Memory capacity	Word range	Bit range	Unit
4	16 to 72 K	16 to 1 K	1 to 72	bit
16	64 to 72 K	64 to 4 K	1 to 18	bit

### 3. Clock synchronous register file (3 addresses : 1 W, 2 R)

Column type	Memory capacity	Word range	Bit range	Unit
1	4608	4 to 64	1 to 72	bit

### 4. Clock synchronous register file (4 addresses : 2 W, 2 R)

Column type	Memory capacity	Word range	Bit range	Unit
1	4608	4 to 64	1 to 72	bit

### 5. Clock synchronous ROM (1 addresses, 1 R)

Column type	Memory capacity	Word range	Bit range	Unit
16	256 to 512 K	128 to 4 K	2 to 128	bit

### 6. Clock synchronous delay line memory (2 addresses : 1 W, 1 R)

Column type	Memory capacity	Word range	Bit range	Unit
8	256 to 32 K	32 to 1 K	8 to 32	bit
16	384 to 32 K	64 to 2 K	6 to 16	bit
32	512 to 32 K	128 to 4 K	4 to 8	bit

# CS81 Series

## ■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating		Unit
		Min	Max	
Supply voltage*1	V <sub>DD</sub>	-0.5	+2.5*2	V
			+4.0*3	
Input voltage*1	V <sub>I</sub>	-0.5	V <sub>DD</sub> +0.5 ( ≤ 2.5 V) *2	V
			V <sub>DD</sub> +0.5 ( ≤ 4.0 V) *3	
Output voltage*1	V <sub>O</sub>	-0.5	V <sub>DD</sub> +0.5 ( ≤ 2.5 V) *2	V
			V <sub>DD</sub> +0.5 ( ≤ 4.0 V) *3	
Storage temperature	T <sub>st</sub>	-55	+125	°C
Junction temperature	T <sub>j</sub>	-40	+125	°C
Output current*4	I <sub>o</sub>	—	±4	mA
Input signal transmitting rate	R <sub>i</sub>	—	Clock input*5 : 200 Normal input : 100	Mbps*6
Output signal transmitting rate	R <sub>o</sub>	—	100	Mbps*6
Output load capacitance	C <sub>o</sub>	—	3000/R <sub>o</sub>	pF
Supply pin current	I <sub>D</sub>	—	*7	mA

\*1 : V<sub>SS</sub> = 0 V

\*2 : Internal gate part in case of single power supply or dual power supply

\*3 : I/O part in case 3.3 V I/F or 2.5 V I/F is used by dual power supply.

\*4 : DC current which continues more than 10 ms, or average DC current

\*5 : in case of I/O cell for clock input

\*6 : bps = bit per second

\*7 : Supply pin current for one V<sub>DD</sub>/GND pin

Frame	Source type	Maximum current [mA]		Number of layer
		Standard source	Additional source	
YS, YI	V <sub>DDE</sub> , V <sub>DDI</sub> , V <sub>DD</sub> , V <sub>SS</sub>	68	68	4, 5
	V <sub>DDE</sub>	39	39	3
	V <sub>DDI</sub> , V <sub>DD</sub> , V <sub>SS</sub>	68	68	
B	V <sub>DDE</sub> , V <sub>DDI</sub> , V <sub>DD</sub> , V <sub>SS</sub>	43	30	—

**WARNING:** Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

## ■ RECOMMENDED OPERATING CONDITIONS

- Single power supply ( $V_{DD} = +1.8 \text{ V} \pm 0.15 \text{ V}$ )

( $V_{SS} = 0 \text{ V}$ )

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Supply voltage (1.8 V supply voltage)	$V_{DD}$	1.65	1.8	1.95	V
“H” level input voltage (1.8 V CMOS)	$V_{IH}$	$V_{DD} \times 0.65$	—	$V_{DD} + 0.3$	V
“L” level input voltage (1.8 V CMOS)	$V_{IL}$	-0.3	—	$V_{DD} \times 0.35$	V
Junction temperature	$T_j$	-40	—	+125	°C

- Dual power supply ( $V_{DDE} = +3.3 \text{ V} \pm 0.3 \text{ V}$ ,  $V_{DDI} = +1.8 \text{ V} \pm 0.15 \text{ V}$ )

( $V_{SS} = 0 \text{ V}$ )

Parameter		Symbol	Value			Unit
			Min	Typ	Max	
Supply voltage	1.8 V supply voltage	$V_{DDI}$	1.65	1.8	1.95	V
	3.3 V supply voltage	$V_{DDE}$	3.0	3.3	3.6	
“H” level input voltage	1.8 V CMOS	$V_{IH}$	$V_{DDI} \times 0.65$	—	$V_{DDI} + 0.3$	V
	3.3 V CMOS					
“L” level input voltage	1.8 V CMOS	$V_{IL}$	-0.3	—	$V_{DDI} \times 0.35$	V
	3.3 V CMOS					
Junction temperature		$T_j$	-40	—	+125	°C

- Dual power supply ( $V_{DDE} = +3.3 \text{ V} \pm 0.3 \text{ V}$ ,  $V_{DDI} = +1.5 \text{ V} \pm 0.1 \text{ V} / +1.1 \text{ V} \pm 0.1 \text{ V}$ )

( $V_{SS} = 0 \text{ V}$ )

Parameter		Symbol	Value			Unit
			Min	Typ	Max	
Supply voltage		$V_{DDE}$	3.0	3.3	3.6	V
		$V_{DDI}$	1.0	1.1	1.2	V
			1.4	1.5	1.6	V
“H” level input voltage	3.3 V CMOS	$V_{IH}$	2.0	—	$V_{DDE} + 0.3$	V
“L” level input voltage	3.3 V CMOS	$V_{IL}$	-0.3	—	+0.8	V
Junction temperature		$T_j$	-40	—	+125	°C

# CS81 Series

- Dual power supply ( $V_{DDE} = +2.5\text{ V} \pm 0.2\text{ V}$ ,  $V_{DDI} = +1.8\text{ V} \pm 0.15\text{ V}$ )

( $V_{SS} = 0\text{ V}$ )

Parameter		Symbol	Value			Unit
			Min	Typ	Max	
Supply voltage		$V_{DDE}$	2.3	2.5	2.7	V
		$V_{DDI}$	1.65	1.8	1.95	V
“H” level input voltage	1.8 V CMOS	$V_{IH}$	$V_{DDI} \times 0.65$	—	$V_{DDI} + 0.3$	V
	2.5 V CMOS		1.7	—	$V_{DDE} + 0.3$	V
“L” level input voltage	1.8 V CMOS	$V_{IL}$	-0.3	—	$V_{DDI} \times 0.35$	V
	2.5 V CMOS		-0.3	—	+0.7	V
Junction temperature		$T_j$	-40	—	+125	°C

- Dual power supply ( $V_{DDE} = +2.5\text{ V} \pm 0.2\text{ V}$ ,  $V_{DDI} = +1.5\text{ V} \pm 0.1\text{ V} / +1.1\text{ V} \pm 0.1\text{ V}$ )

( $V_{SS} = 0\text{ V}$ )

Parameter		Symbol	Value			Unit
			Min	Typ	Max	
Supply voltage		$V_{DDE}$	2.3	2.5	2.7	V
		$V_{DDI}$	1.0	1.1	1.2	V
			1.4	1.5	1.6	V
“H” level input voltage	2.5 V CMOS	$V_{IH}$	1.7	—	$V_{DDE} + 0.3$	V
“L” level input voltage	2.5 V CMOS	$V_{IL}$	-0.3	—	+0.7	V
Junction temperature		$T_j$	-40	—	+125	°C

**WARNING:** The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device’s electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

## ■ ELECTRICAL CHARACTERISTICS

### 1. DC characteristics

- Signal power supply :  $V_{DD} = 1.8 \text{ V}$

( $V_{DD} = 1.8 \text{ V} \pm 0.15 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ,  $T_j = -40 \text{ }^\circ\text{C}$  to  $+125 \text{ }^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value			Unit
			Min	Typ	Max	
Supply Current	$I_{DD5}$	—	—	—	*	mA
“H” level output voltage	$V_{OH}$	$I_{OH} = -100 \mu\text{A}$	$V_{DD} - 0.2$	—	$V_{DD}$	V
“L” level output voltage	$V_{OL}$	$I_{OL} = +100 \mu\text{A}$	0	—	0.2	V
Input leakage current	$I_L$	—	—	—	$\pm 5$	$\mu\text{A}$
Pull up/Pull down resistance	$R_P$	Pull up $V_{IL} = 0$ Pull down $V_{IH} = V_{DD}$	—	18	—	$\text{k}\Omega$

\* : For details of YS, YI, B frame of CS81 series, contact Fujitsu Microelectronics.

- Dual power supply :  $V_{DDE} = 3.3 \text{ V}$ ,  $V_{DDI} = 1.8 \text{ V}$

( $V_{DDE} = 3.3 \text{ V} \pm 0.3 \text{ V}$ ,  $V_{DDI} = 1.8 \text{ V} \pm 0.15 \text{ V} / 1.5 \text{ V} \pm 0.1 \text{ V} / 1.1 \text{ V} \pm 0.1 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ,  $T_j = -40 \text{ }^\circ\text{C}$  to  $+125 \text{ }^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value			Unit
			Min	Typ	Max	
Supply Current	$I_{DD5}$	—	—	—	*1	mA
“H” level output voltage	$V_{OH4}$	3.3 V Output $I_{OH} = -100 \mu\text{A}$	$V_{DDE} - 0.2$	—	$V_{DDE}$	V
	$V_{OH2}$	1.8 V Output $I_{OH} = -100 \mu\text{A}$	$V_{DDI} - 0.2$	—	$V_{DDI}$	V
“L” level output voltage	$V_{OL4}$	3.3 V Output $I_{OL} = 100 \mu\text{A}$	0	—	0.2	V
	$V_{OL2}$	1.8 V Output $I_{OL} = 100 \mu\text{A}$	0	—	0.2	V
“H” level output V-I characteristics	—	3.3 V $V_{DDE} = 3.3 \text{ V} \pm 0.3 \text{ V}$	*2			—
		1.8 V $V_{DDI} = 1.8 \text{ V} \pm 0.15 \text{ V}$	—			—
“L” level output V-I characteristics	—	3.3 V $V_{DDE} = 3.3 \text{ V} \pm 0.3 \text{ V}$	*2			—
		1.8 V $V_{DDI} = 1.8 \text{ V} \pm 0.15 \text{ V}$	—			—
Input leakage current	$I_L$	—	—	—	$\pm 5$	$\mu\text{A}$
Pull up/Pull down resistance	$R_P$	1.8 V Pull up $V_{IL} = 0$ Pull down $V_{IH} = V_{DDI}$	—	18	—	$\text{k}\Omega$
		3.3 V Pull up $V_{IL} = 0$ Pull down $V_{IH} = V_{DDE}$	10	33	80	

\*1 : For details of YS, YI, B frame of CS81 series, contact Fujitsu Microelectronics.

\*2 : Refer to the Fig.1 to 2.

# CS81 Series

- **Dual power supply** :  $V_{DDE} = 2.5 \text{ V}$ ,  $V_{DDI} = 1.8 \text{ V} / 1.5 \text{ V} / 1.1 \text{ V}$   
 ( $V_{DDE} = 2.5 \text{ V} \pm 0.2 \text{ V}$ ,  $V_{DDI} = 1.8 \text{ V} \pm 0.15 \text{ V} / 1.5 \text{ V} \pm 0.1 \text{ V} / 1.1 \text{ V} \pm 0.1 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ,  $T_j = -40 \text{ }^\circ\text{C}$  to  $+125 \text{ }^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value			Unit
			Min	Typ	Max	
Supply Current	$I_{DD5}$	—	—	—	*	mA
“H” level output voltage	$V_{OH3}$	2.5 V Output $I_{OH} = -100 \mu\text{A}$	$V_{DDE} - 0.2$	—	$V_{DDE}$	V
	$V_{OH2}$	1.8 V Output $I_{OH} = -100 \mu\text{A}$	$V_{DDI} - 0.2$	—	$V_{DDI}$	V
“L” level output voltage	$V_{OL3}$	2.5 V Output $I_{OL} = 100 \mu\text{A}$	0	—	0.2	V
	$V_{OL2}$	1.8 V Output $I_{OL} = 100 \mu\text{A}$	0	—	0.2	V
Input leakage current	$I_L$	—	—	—	$\pm 5$	$\mu\text{A}$
Pull up/Pull down resistance	$R_P$	2.5 V Pull up $V_{IL}=0$ Pull down $V_{IH}=V_{DDE}$	—	25	—	k $\Omega$
		1.8 V Pull up $V_{IL}=0$ Pull down $V_{IH}=V_{DDI}$	—	18	—	

\* : For details of YS, YI, B frame of CS81 series, contact Fujitsu Microelectronics.

## • V-I Characteristics

Conditions (Fig 1, 2) Min : Process = Slow,  $T_j = +125\text{ }^\circ\text{C}$ ,  $V_{DD} = 3.6\text{ V}$   
Typ : Process = TYPICAL,  $T_j = +25\text{ }^\circ\text{C}$ ,  $V_{DD} = 3.3\text{ V}$   
Max : Process = FAST,  $T_j = -40\text{ }^\circ\text{C}$ ,  $V_{DD} = 3.0\text{ V}$

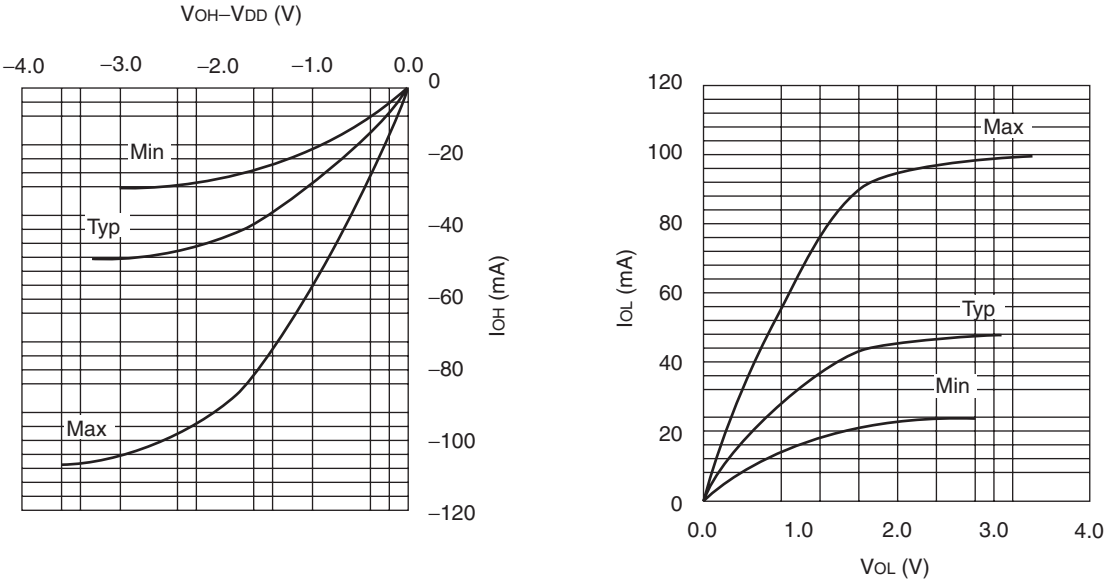


Fig.1 V-I characteristics (3.3 V normal I/O L, M type)

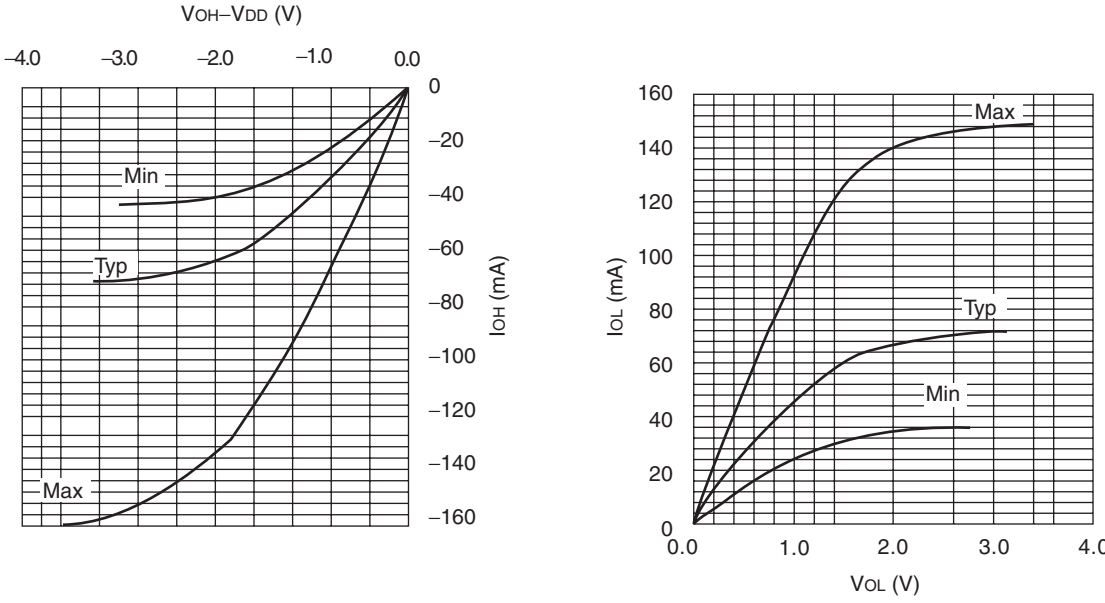


Fig.2 V-I characteristics (3.3 V normal I/O H, V type)

# CS81 Series

## 2. AC characteristics

( $V_{DD} = 1.8 \text{ V} \pm 0.15 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ,  $T_j = -40 \text{ }^\circ\text{C}$  to  $+125 \text{ }^\circ\text{C}$ )

Parameter	Symbol	Rating			Unit
		Min	Typ	Max*	
Delay time	$t_{pd}^{*1}$	$typ^{*2} \times tmin^{*3}$	$typ^{*2} \times ttyp^{*3}$	$typ^{*2} \times tmax^{*3}$	ns

\*1 : Delay time = propagation delay time, enable time, disable time

\*2 : "typ" is calculated based on the cell specifications.

\*3 : Measurement conditions.

Measurement condition	tmin	ttyp	tmax
$V_{DD} = 1.8 \text{ V} \pm 0.15 \text{ V}$ , $V_{SS} = 0 \text{ V}$ , $T_j = -40 \text{ }^\circ\text{C}$ to $+125 \text{ }^\circ\text{C}$	0.64	1.00	1.58
$V_{DD} = 1.5 \text{ V} \pm 0.10 \text{ V}$ , $V_{SS} = 0 \text{ V}$ , $T_j = -40 \text{ }^\circ\text{C}$ to $+125 \text{ }^\circ\text{C}$	0.83	1.31	2.05
$V_{DD} = 1.1 \text{ V} \pm 0.10 \text{ V}$ , $V_{SS} = 0 \text{ V}$ , $T_j = -40 \text{ }^\circ\text{C}$ to $+125 \text{ }^\circ\text{C}$	1.37	2.45	4.88

Note :  $t_{pd \text{ max}}$  is calculated according to the maximum junction temperature ( $T_j$ ) .

## ■ INPUT/OUTPUT PIN CAPACITANCE

( $T_j = +25 \text{ }^\circ\text{C}$ ,  $V_{DD} = V_i = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$ )

Parameter	Symbol	Requirements	Unit
Input pin	$C_{IN}$	Max 16	pF
Output pin	$C_{OUT}$	Max 16	pF
I/O pin	$C_{I/O}$	Max 16	pF

Note : Capacitance varies according to the package and the location of the pin.

## ■ DESIGN METHOD

SCCAD2 is the standard cell integrated design environment providing three major functions, enabling high-quality, large-scale system LSIs to be developed in a shorter period of time. They include: the timing driven layout function for automatic placement/routing based on timing constraints to prevent timing problems after layout, the function for shortening the development cycle time by dividing a large-scale circuit and performing simultaneous logical/physical design of multiple circuits, and the function for automatically generating power/signal wiring patterns while evaluating the supply voltage drop, signal noise, delay penalty, and crosstalk (Contact your nearest Fujitsu Microelectronics office for more information and availability).

## ■ PACKAGES

The table below lists the package types available.

Consult Fujitsu Microelectronics for the combination of each package and the time of availability.

Package	Pin count	Material
TAB-BGA	304	Plastic
	352	Plastic
	480	Plastic
	560	Plastic
	660	Plastic
	720	Plastic
EBGA	576	Plastic
	660	Plastic
	672	Plastic
HQFP	208	Plastic
	240	Plastic
	256	Plastic
	304	Plastic
TQFP	100	Plastic
	120	Plastic
LQFP	144	Plastic
	176	Plastic
	208	Plastic
FBGA	288	Plastic
FCBGA	1089	Plastic
	1225	Plastic
	1369	Plastic
	1681	Plastic
	1849	Plastic
	2116	Plastic

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